

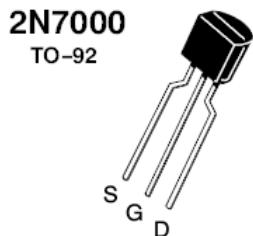
Features

- Low On-Resistance
- ESD Protection
- High Speed Switching
- Low Voltage Drive

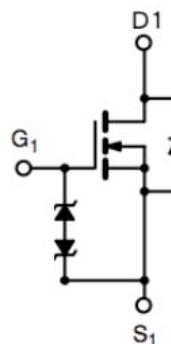
PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (mA)
60	5 @ $V_{GS} = 10V$	100
	5.5 @ $V_{GS} = 5V$	100

Block Diagram



Pin Definition:
S. Source
G. Gate
D. Drain



N-Channel MOSFET

Absolute Maximum Rating ($T_a = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current	Continuous @ $T_A=25^\circ C$	I_D	mA
	Pulsed	I_{DM}	
Drain Reverse Current	Continuous @ $T_A=25^\circ C$	I_{DR}	mA
	Pulsed	I_{DMR}	
Maximum Power Dissipation	P_D	400	mW
Operating Junction Temperature	T_J	+150	°C
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C

Thermal Performance

Parameter	Symbol	Limit	Unit
Lead Temperature (1/8" from case)	T_L	10	S
Junction to Ambient Thermal Resistance (PCB mounted)	$R\theta_{JA}$	357	°C/W

Notes:

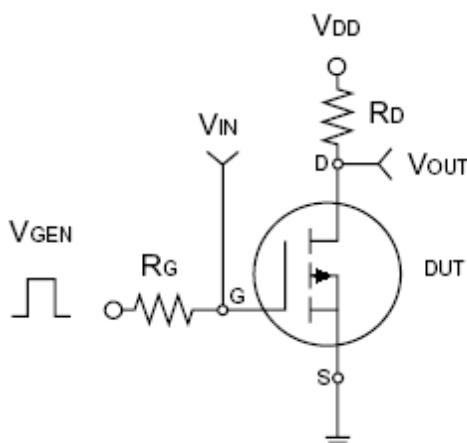
- a. Pulse width limited by the Maximum junction temperature
- b. Surface Mounted on FR4 Board, $t \leq 5$ sec.

Electrical Specifications ($T_a = 25^\circ\text{C}$, unless otherwise noted)

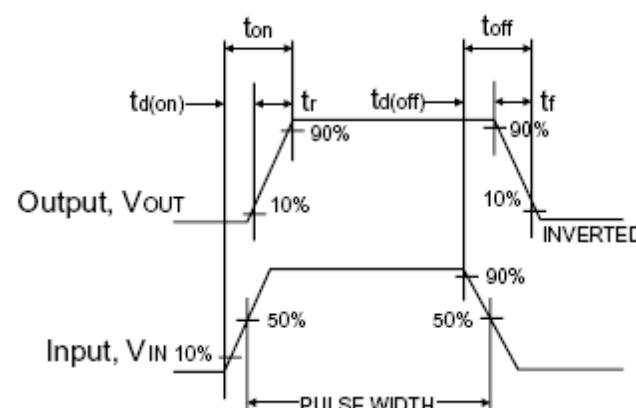
Parameter	Conditions	Symbol	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}$, $I_D = 10\mu\text{A}$	BV_{DSS}	60	--	--	V
Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$	$V_{GS(\text{TH})}$	1.0	--	2.5	V
Gate Body Leakage	$V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$	I_{GSS}	--	--	± 10	μA
Zero Gate Voltage Drain Current	$V_{DS} = 60\text{V}$, $V_{GS} = 0\text{V}$	I_{DSS}	--	--	1.0	μA
Drain-Source On-State Resistance	$V_{GS} = 10\text{V}$, $I_D = 100\text{mA}$	$R_{DS(\text{ON})}$	--	3	5	Ω
	$V_{GS} = 5\text{V}$, $I_D = 100\text{mA}$		--	3.6	5.5	
Forward Transconductance	$V_{DS} = 10\text{V}$, $I_D = 200\text{mA}$	g_{fs}	100	--	--	mS
Diode Forward Voltage	$I_S = 300\text{mA}$, $V_{GS} = 0\text{V}$	V_{SD}	--	0.9	1.2	V
Dynamic^b						
Total Gate Charge	$V_{DS} = 10\text{V}$, $I_D = 250\text{mA}$, $V_{GS} = 4.5\text{V}$	Q_g	--	0.4	--	nC
Input Capacitance	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1.0\text{MHz}$	C_{iss}	--	7.32	--	pF
Output Capacitance		C_{oss}	--	3.42	--	
Reverse Transfer Capacitance		C_{rss}	--	7.63	--	
Switching^c						
Turn-On Delay Time	$V_{DD} = 30\text{V}$, $R_G = 10\Omega$	$t_{d(on)}$	--	25	--	nS
Turn-Off Delay Time		$t_{d(off)}$	--	35	--	

Notes:

- a. pulse test: PW $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- b. For DESIGN AID ONLY, not subject to production testing.
- c. Switching time is essentially independent of operating temperature.



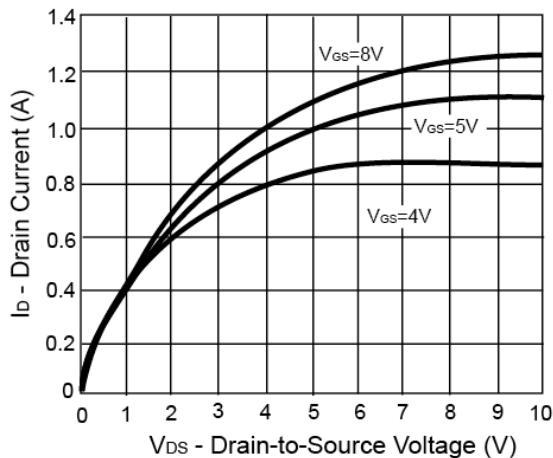
Switching Test Circuit



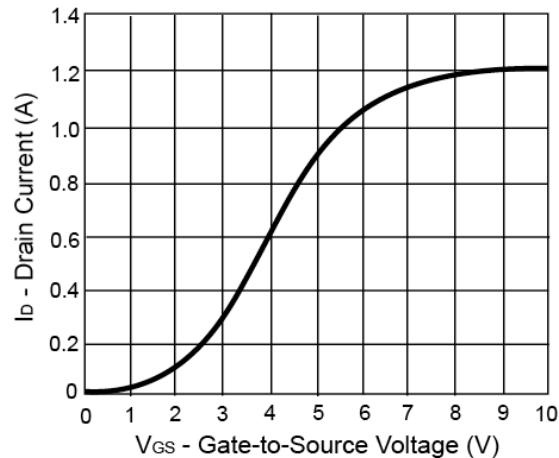
Switching Waveforms

Electrical Characteristics Curve ($T_a = 25^\circ\text{C}$, unless otherwise noted)

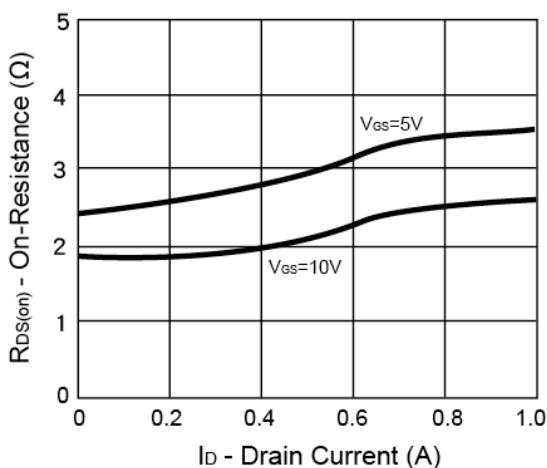
Output Characteristics



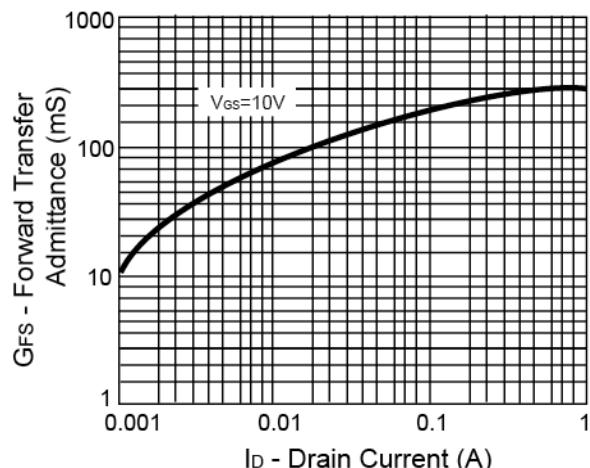
Transfer Characteristics



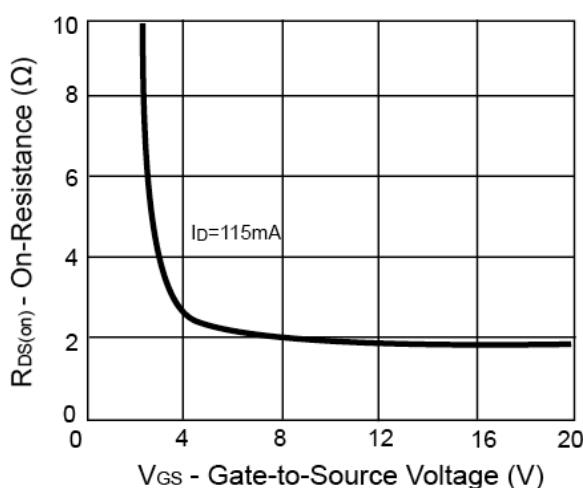
On-Resistance vs. Drain Current



Forward Transfer Admittance vs. Drain Current



On-Resistance vs. Gate-Source Voltage



Power Derating Curve

